

Notice of References Cited	Application/Control No. 10/748,559		Applicant(s)/Patent Under Reexamination BRASK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,835,639	12-2004	Rotondaro et al.	438/592
	B	US-6,475,908	11-2002	Lin et al.	438/659
	C	US-6,794,306	09-2004	Kim et al.	438/752
	D	US-2004/0099916	05-2004	Rotondaro et al.	257/412
	E	US-6,770,568	08-2004	Brask, Justin K.	438/746
	F	US-6,841,441	01-2005	Ang et al.	438/232
	G	US-6,365,450	04-2002	Kim, Hyeon-Seag	438/216
	H	US-6,518,154	02-2003	Buynoski et al.	438/585
	I	US-6,204,103	03-2001	Bai et al.	438/224
	J	US-6,846,734	01-2005	Amos et al.	438/592
	K	US-6,642,094	11-2003	Rotondaro et al.	438/199
	L	US-6,858,483	02-2005	Doczy et al.	438/199
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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